

**Search Notes**

Application/Control No.

10/748,229

Examiner

Devin Hanan

Applicant(s)/Patent under  
Reexamination

KIM ET AL.

Art Unit

3745

**SEARCHED**

Class	Subclass	Date	Examiner
415	58.4		
	58.2-58.3		
	228		
416	181		
	185		
	186R		
	188		
417	423.1		
	370	9/15/2005	DH

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
consulted Chris Verdier class 415 and 416	9/14/2005	DH
consulted Chuch Freay class 417	9/15/2005	DH